

# SANYO Semiconductors DATA SHEET

# 2SC6080 — 50V / 13A High-Speed Switching Applications

# **Applications**

· High-speed switching applications (switching regulator, driver circuit).

#### **Features**

- · Adoption of MBIT process.
- · Large current capacitance.
- · Low collector-to-emitter saturation voltage.
- · High-speed switching.

#### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	Vcво		60	V
Collector-to-Emitter Voltage	VCES		60	V
Collector-to-Emitter Voltage	VCEO		50	V
Emitter-to-Base Voltage	VEBO		6	V
Collector Current	IC		13	Α
Collector Current (Pulse)	ICP	PW≤10μs, duty cycle≤10%	15	Α
Base Current	IΒ		2	А
Collector Dissipation	D-		2	W
	PC	Tc=25°C	25	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	ICBO	V <sub>CB</sub> =40V, I <sub>E</sub> =0A			10	μΑ
Emitter Cutoff Current	IEBO	VEB=4V, IC=0A			10	μΑ
DC Current Gain	hFE1	V <sub>CE</sub> =2V, I <sub>C</sub> =270mA	200		560	
	hFE2	VCE=2V, IC=8.1A	50			

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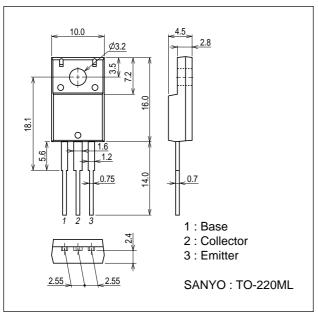
## 2SC6080

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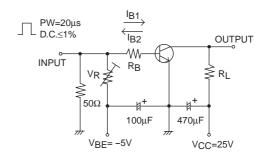
Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Oill
Gain-Bandwidth Product	fT	VCE=5V, IC=1A		180		MHz
Output Capacitance	Cob	V <sub>CB</sub> =10V, f=1MHz		73		pF
Collector-to-Emitter Saturation Voltage	VCE(sat)	IC=6A, IB=300mA		200	400	mV
Base-to-Emitter Saturation Voltage	VBE(sat)	IC=6A, IB=300mA			1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	I <sub>C</sub> =100μA, I <sub>E</sub> =0A	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CES	IC=100μA, RBE=0Ω	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	IC=1mA, RBE=∞	50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I <sub>E</sub> =100μA, I <sub>C</sub> =0A	6			V
Turn-ON Time	ton	See specified Test Circuit.		46		ns
Storage Time	t <sub>stg</sub>	See specified Test Circuit.		450		ns
Fall Time	tf	See specified Test Circuit.		35		ns

## **Package Dimensions**

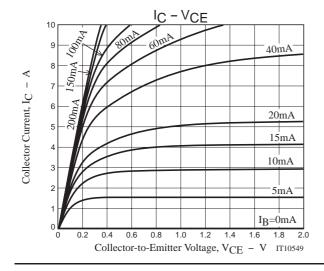
unit : mm 7508-002

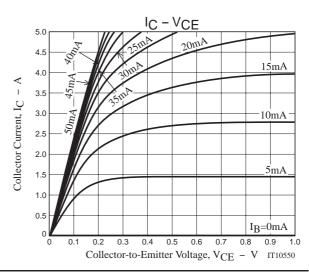


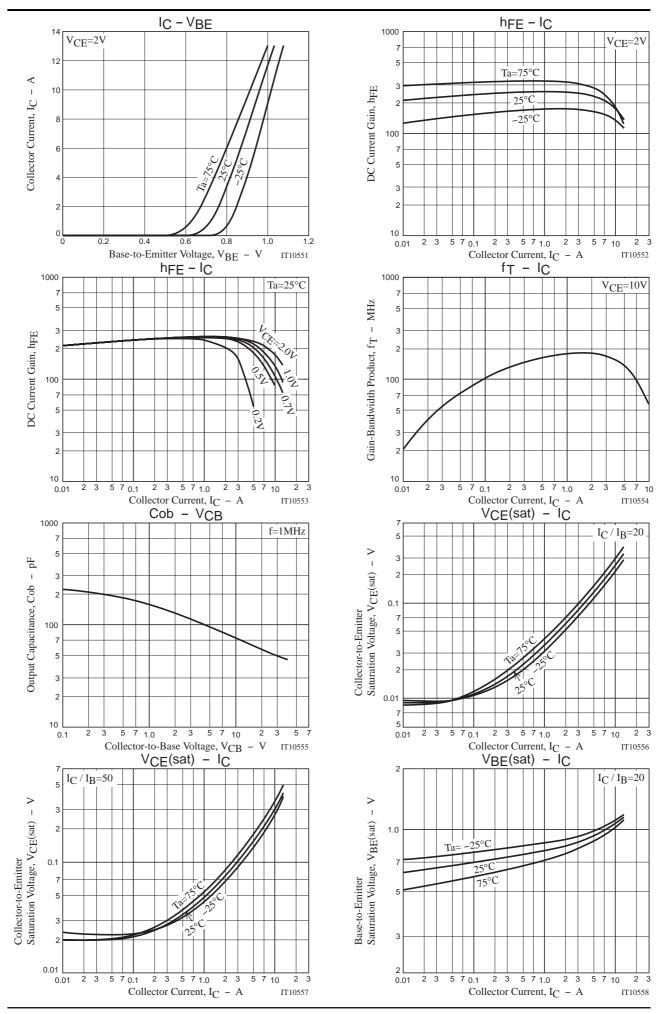
# **Switching Time Test Circuit**

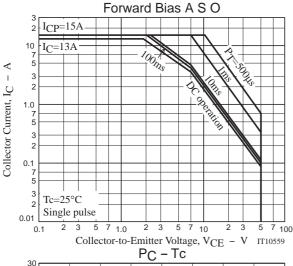


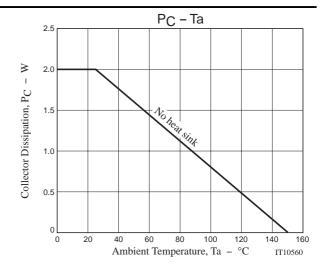
$$I_{C}=20I_{B1}=-20I_{B2}=5A$$

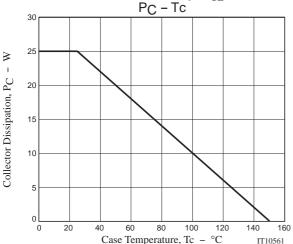












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